

STFW3N170, STW3N170

N-channel 1700 V, 8 Ωtyp., 2.3 A, PowerMESH™ Power MOSFET in TO-3FP and TO-247 packages

Datasheet - preliminary data

Features

Order codes	V _{DSS}	R _{DS(on)} max	I _D
STFW3N170	1700 V	12 Ω	2.3 A
STW3N170	1700 V	12 32	2.0 A

- Intrinsic capacitances and Qg minimized
- TO-3PF for higher creepage between leads
- High speed switching
- 100% avalanche tested

Applications

Switching applications

Description

These Power MOSFETs are designed using the company's consolidated strip layout-based MESH OVERLAY™ process. The result is a product that matches or improves on the performance of comparable standard parts from other manufacturers.

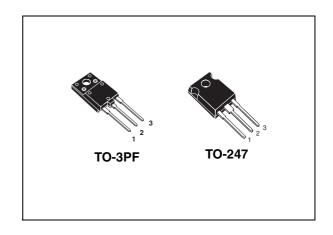


Figure 1. Internal schematic diagram

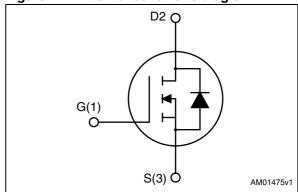


Table 1. Device summary

Oreder codes	Marking	Package	Packaging
STFW3N170	3N170	TO-3PF	Tube
STW3N170	314170	TO-247	Tube

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STFW3N170, STW3N170 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Cumhal	Barrantar	Value	Unit	
Symbol	Parameter	TO-3PF	TO-247	- Unit
V _{DS}	Drain-source voltage	1700)	V
V _{GS}	Gate-source voltage	± 30		V
I _D	Drain current (continuous) at T _C = 25 °C	(continuous) at $T_C = 25 ^{\circ}C$ 2.3 ⁽¹⁾ 2.3		
I _D	Drain current (continuous) at T _C = 100 °C 1.45 ⁽¹⁾ 1.45			
I _{DM}	Drain current (pulsed)	9.2 ⁽¹⁾ 9.2		Α
P _{TOT}	Total dissipation at $T_C = 25 ^{\circ}C$ 63 160			
I _{AR}	Max current during repetitive or single pulse avalanche (pulse width limited by T _{jmax})	TBD		А
E _{AS}	Single pulse avalanche energy (starting T_j = 25 °C, $I_D = I_{AR}$, V_{DD} = 50 V)	TBD		mJ
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; T _C = 25 °C)	s to external heat sink 3500		V
T _{stg}	Storage temperature	EE to 1	FO	°C
T _j	Max. operating junction temperature	-55 to 1	50	°C

^{1.} Limited by maximum junction temperature

Table 3. Thermal data

Symbol	Parameter TO-3PF TO-247			
R _{thj-case}	Thermal resistance junction-case max	2 0.78		°C/W
R _{thj-amb}	Thermal resistance junction-amb max	50		°C/W

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	1700			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	$V_{DS} = 1700 \text{ V},$ $V_{DS} = 1700 \text{ V}, T_c = 125 ^{\circ}\text{C}$			10 500	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20 V			100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 1.2 A		8	12	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 100 V, f =1 MHz, V _{GS} = 0	-	1250 110 14	-	pF pF pF
Rg	Gate input resistance	f=1 MHz Gate DC Bias=0 Test signal level=20 mV open drain	-	TBD	-	Ω
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 1360 V, I_{D} = 2.3 A V_{GS} = 10 V (see Figure 3)	-	28 TBD TBD	-	nC nC nC

Table 6. Switching times

	_					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$t_{ m d(on)} \ t_{ m r} \ t_{ m d(off)} \ t_{ m f}$	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DS} = 850 \text{ V}, I_{D} = 1.2 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 2)	-	TBD TBD TBD TBD	-	ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)	T _J =25 °C	-		2.3 9.2	A A
V _{SD} ⁽¹⁾	Forward on voltage	$I_{SD} = 2.3 \text{ A}, V_{GS} = 0$	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 2.3 A, di/dt =100 A/µs, V_{DD} = 60 V (see Figure 4)	-	TBD TBD TBD		ns μC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$V_{DD} = 60 \text{ V}$ di/dt =100 A/µs, $I_{SD} = 2.3 \text{ A}$ $T_j = 150 ^{\circ}\text{C}$ (see Figure 4)	-	TBD TBD TBD		ns μC A

^{1.} Pulsed: pulse duration = 300 μs, duty cycle 1.5%

Test circuits STFW3N170, STW3N170

3 Test circuits

Figure 2. Switching times test circuit for resistive load

Figure 3. Gate charge test circuit

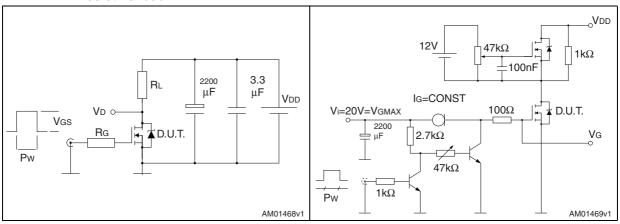


Figure 4. Test circuit for inductive load switching and diode recovery times

Figure 5. Unclamped inductive load test circuit

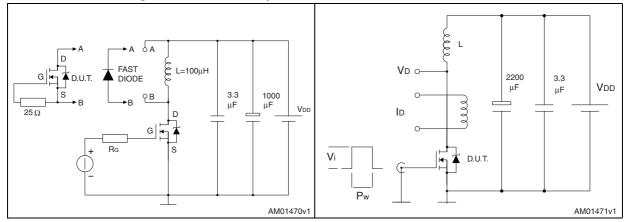
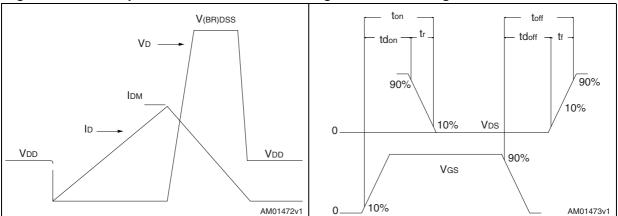


Figure 6. Unclamped inductive waveform

Figure 7. Switching time waveform



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.



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Table 8. TO-3PF mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	5.30		5.70
С	2.80		3.20
D	3.10		3.50
D1	1.80		2.20
E	0.80		1.10
F	0.65		0.95
F2	1.80		2.20
G	10.30		11.50
G1		5.45	
Н	15.30		15.70
L	9.80	10	10.20
L2	22.80		23.20
L3	26.30		26.70
L4	43.20		44.40
L5	4.30		4.70
L6	24.30		24.70
L7	14.60		15
N	1.80		2.20
R	3.80		4.20
Dia	3.40		3.80

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Figure 8. **TO-3PF drawing** L3 D E c D1 Dia L2 L6 L7 F2(3x) F(3x) G1 Н R L5 - N ∤

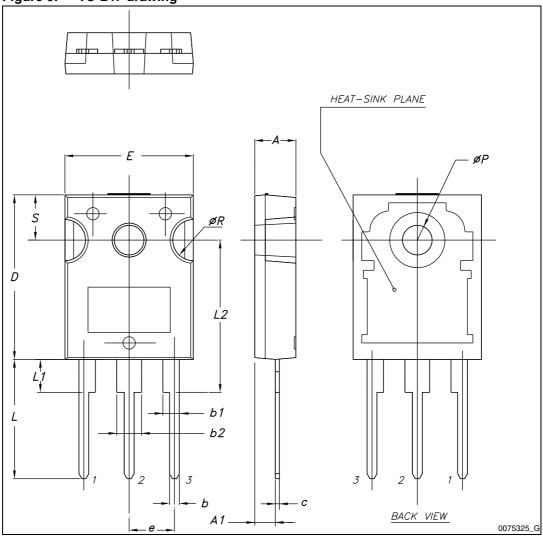
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7627132_C

Table 9. TO-247 mechanical data

Dim.		mm.	
Dim.	Min.	Тур.	Max.
Α	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

Figure 9. TO-247 drawing



Revision history STFW3N170, STW3N170

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
17-Jan-2013	1	First release

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